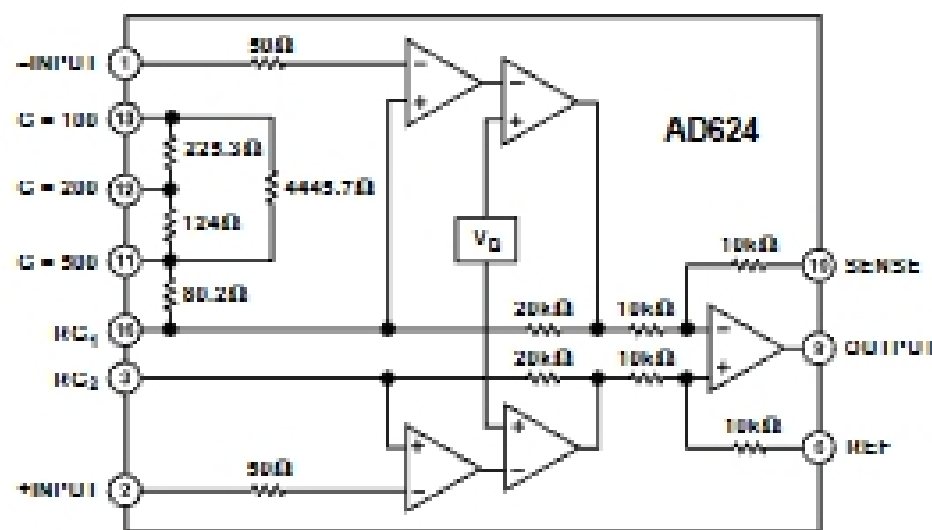


FEATURES

- Low Noise:** 0.2 μV p-p 0.1 Hz to 10 Hz
- Low Gain TC:** 5 ppm max ($G = 1$)
- Low Nonlinearity:** 0.001% max ($G = 1$ to 200)
- High CMRR:** 130 dB min ($G = 500$ to 1000)
- Low Input Offset Voltage:** 25 μV , max
- Low Input Offset Voltage Drift:** 0.25 $\mu\text{V}/^\circ\text{C}$ max
- Gain Bandwidth Product:** 25 MHz
- Pin Programmable Gains of 1, 100, 200, 500, 1000**
- No External Components Required**
- Internally Compensated**

FUNCTIONAL BLOCK DIAGRAM



PRODUCT DESCRIPTION

The AD624 is a high precision, low noise, instrumentation amplifier designed primarily for use with low level transducers, including load cells, strain gauges and pressure transducers. An outstanding combination of low noise, high gain accuracy, low gain temperature coefficient and high linearity make the AD624 ideal for use in high resolution data acquisition systems.

The AD624C has an input offset voltage drift of less than 0.25 $\mu\text{V}/^\circ\text{C}$, output offset voltage drift of less than 10 $\mu\text{V}/^\circ\text{C}$, CMRR above 80 dB at unity gain (130 dB at $G = 500$) and a maximum nonlinearity of 0.001% at $G = 1$. In addition to these outstanding dc specifications, the AD624 exhibits superior ac performance as well. A 25 MHz gain bandwidth product, 5 V/ μs slew rate and 15 μs settling time permit the use of the AD624 in high speed data acquisition applications.

The AD624 does not need any external components for pre-trimmed gains of 1, 100, 200, 500 and 1000. Additional gains such as 250 and 333 can be programmed within one percent accuracy with external jumpers. A single external resistor can also be used to set the 624's gain to any value in the range of 1 to 10,000.

PRODUCT HIGHLIGHTS

1. The AD624 offers outstanding noise performance. Input noise is typically less than 4 nV/ $\sqrt{\text{Hz}}$ at 1 kHz.
2. The AD624 is a functionally complete instrumentation amplifier. Pin programmable gains of 1, 100, 200, 500 and 1000 are provided on the chip. Other gains are achieved through the use of a single external resistor.
3. The offset voltage, offset voltage drift, gain accuracy and gain temperature coefficients are guaranteed for all pretrimmed gains.
4. The AD624 provides totally independent input and output offset nulling terminals for high precision applications. This minimizes the effect of offset voltage in gain ranging applications.
5. A sense terminal is provided to enable the user to minimize the errors induced through long leads. A reference terminal is also provided to permit level shifting at the output.

REV. C

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AD624—SPECIFICATIONS (@ $V_S = \pm 15\text{ V}$, $R_L = 2\text{ k}\Omega$ and $T_A = +25^\circ\text{C}$, unless otherwise noted)

Model	AD624A			AD624B			AD624C			AD624S			Units
	Min	Typ	Max	Min	Typ	Max	Min	Typ	Max	Min	Typ	Max	
GAIN													
Gain Equation (External Resistor Gain Programming)	$\left[\frac{40,000}{R_G} + 1 \right] \pm 20\%$			$\left[\frac{40,000}{R_G} + 1 \right] \pm 20\%$			$\left[\frac{40,000}{R_G} + 1 \right] \pm 20\%$			$\left[\frac{40,000}{R_G} + 1 \right] \pm 20\%$			
Gain Range (Pin Programmable)	1 to 1000			1 to 1000			1 to 1000			1 to 1000			
Gain Error													
G = 1	± 0.05			± 0.03			± 0.02			± 0.05			%
G = 100	± 0.25			± 0.15			± 0.1			± 0.25			%
G = 200, 500	± 0.5			± 0.35			± 0.25			± 0.5			%
Nonlinearity													
G = 1	± 0.005			± 0.003			± 0.001			± 0.005			%
G = 100, 200	± 0.005			± 0.003			± 0.001			± 0.005			%
G = 500	± 0.005			± 0.005			± 0.005			± 0.005			%
Gain vs. Temperature													
G = 1	5			5			5			5			ppm/°C
G = 100, 200	10			10			10			10			ppm/°C
G = 500	25			15			15			15			ppm/°C
VOLTAGE OFFSET (May be Nulled)													
Input Offset Voltage vs. Temperature	200			75			25			75			mV
Output Offset Voltage vs. Temperature	5			3			2			3			mV
Offset Referred to the Input vs. Supply	50			25			10			50			mV/°C
G = 1	70			75			80			75			dB
G = 100, 200	95			105			110			105			dB
G = 500	100			110			115			110			dB
INPUT CURRENT													
Input Bias Current vs. Temperature	± 50			± 25			± 15			± 50			nA
Input Offset Current vs. Temperature	± 20			± 15			± 10			± 20			pA/°C
INPUT													
Input Impedance													
Differential Resistance	10^9			10^9			10^9			10^9			Ω
Differential Capacitance	10			10			10			10			pF
Common-Mode Resistance	10^9			10^9			10^9			10^9			Ω
Common-Mode Capacitance	10			10			10			10			pF
Input Voltage Range ¹													
Max Differ. Input Linear (V_{ID})	± 10			± 10			± 10			± 10			V
Max Common-Mode Linear (V_{CM})	$12\text{ V} - \left(\frac{G}{2} \cdot V_D \right)$			$12\text{ V} - \left(\frac{G}{2} \cdot V_D \right)$			$12\text{ V} - \left(\frac{G}{2} \cdot V_D \right)$			$12\text{ V} - \left(\frac{G}{2} \cdot V_D \right)$			V
Common-Mode Rejection dc to 60 Hz with 1 k Ω Source Imbalance													
G = 1	70			75			80			70			dB
G = 100, 200	100			105			110			100			dB
G = 500	110			120			130			110			dB
OUTPUT RATING $V_{S} = \pm 15\text{ V}$, $R_L = 2\text{ k}\Omega$	± 10			± 10			± 10			± 10			V
DYNAMIC RESPONSE													
Small Signal -3 dB													
G = 1	1			1			1			1			MHz
G = 100	150			150			150			150			kHz
G = 200	100			100			100			100			kHz
G = 500	50			50			50			50			kHz
G = 1000	25			25			25			25			kHz
Slew Rate	5.0			5.0			5.0			5.0			V/μs
Settling Time to 0.01%, 20 V Step													
G = 1 to 200	15			15			15			15			μs
G = 500	35			35			35			35			μs
G = 1000	75			75			75			75			μs
NOISE													
Voltage Noise, 1 kHz													
R.T.L.	4			4			4			4			nV/ $\sqrt{\text{Hz}}$
R.T.O.	75			75			75			75			nV/ $\sqrt{\text{Hz}}$
R.T.L., 0.1 Hz to 10 Hz													
G = 1	10			10			10			10			mV p-p
G = 100	0.3			0.3			0.3			0.3			mV p-p
G = 200, 500, 1000	0.2			0.2			0.2			0.2			mV p-p
Current Noise 0.1 Hz to 10 Hz	60			60			60			60			pA p-p
SENSE INPUT													
R_{DS}	8	10	12	8	10	12	8	10	12	8	10	12	k Ω
I_{DS}	30			30			30			30			mA
Voltage Range	± 10			± 10			± 10			± 10			V
Gain to Output	1			1			1			1			%

Model	AD624A			AD624B			AD624C			AD624S			Units
	Min	Typ	Max	Min	Typ	Max	Min	Typ	Max	Min	Typ	Max	
REFERENCE INPUT													
R_{IN}	16	20	24	16	20	24	16	20	24	16	20	24	k Ω
I_{IN}		30			30			30			30		μ A
Voltage Range	± 10			± 10			± 10			± 10			V
Gain to Output	1			1			1			1			%
TEMPERATURE RANGE													
Specified Performance	-25		+85	-25		+85	-25		+85	-55		+125	$^{\circ}$ C
Storage	-65		+150	-65		+150	-65		+150	-65		+150	$^{\circ}$ C
POWER SUPPLY													
Power Supply Range	± 6		± 15	± 6		± 15	± 6		± 15	± 6		± 15	V
Quiescent Current	3.5		5	3.5		5	3.5		5	3.5		5	mA

NOTES

¹ V_{DI} is the maximum differential input voltage at $G = 1$ for specified nonlinearity, V_{DI} at other gains = $10 V/G$. V_{DI} = actual differential input voltage.

Example: $G = 10$, $V_{DI} = 0.50$. $V_{CM} = 12 V - (10/2 \cdot 0.50 V) = 9.5 V$.

Specifications subject to change without notice.

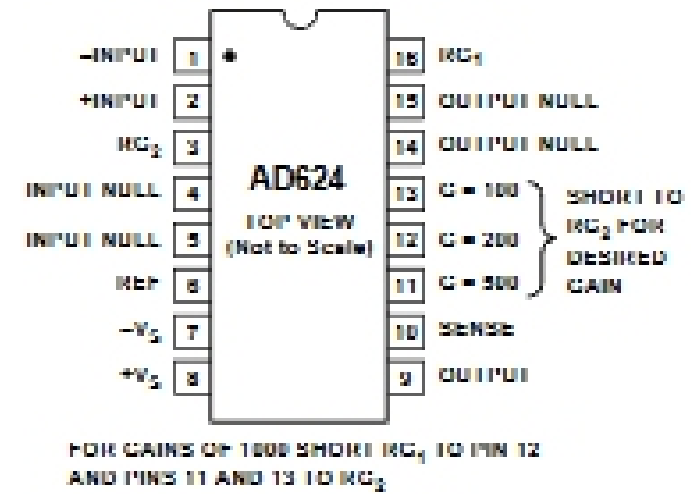
Specifications shown in boldface are tested on all production unit at final electrical test. Results from those tests are used to calculate outgoing quality levels. All min and max specifications are guaranteed, although only those shown in boldface are tested on all production units.

ABSOLUTE MAXIMUM RATINGS*

Supply Voltage	$\pm 18 V$
Internal Power Dissipation	420 mW
Input Voltage	$\pm V_S$
Differential Input Voltage	$\pm V_S$
Output Short Circuit Duration	Indefinite
Storage Temperature Range	$-65^{\circ}C$ to $+150^{\circ}C$
Operating Temperature Range	
AD624A/B/C	$-25^{\circ}C$ to $+85^{\circ}C$
AD624S	$-55^{\circ}C$ to $+125^{\circ}C$
Lead Temperature (Soldering, 60 secs)	$+300^{\circ}C$

*Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

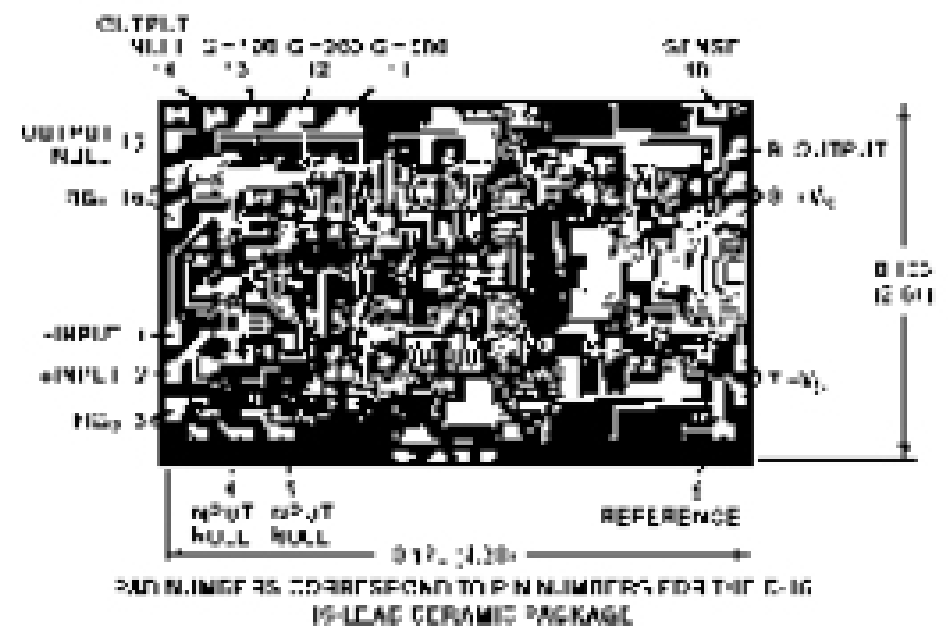
CONNECTION DIAGRAM



FOR GAINS OF 1000 SHORT RG_1 TO PIN 12 AND PINS 11 AND 13 TO RG_2

METALIZATION PHOTOGRAPH

Contact factory for latest dimensions
Dimensions shown in inches and (mm).



ORDERING GUIDE

Model	Temperature Range	Package Description	Package Option
AD624AD	$-25^{\circ}C$ to $+85^{\circ}C$	16-Lead Ceramic DIP	D-16
AD624BD	$-25^{\circ}C$ to $+85^{\circ}C$	16-Lead Ceramic DIP	D-16
AD624CD	$-25^{\circ}C$ to $+85^{\circ}C$	16-Lead Ceramic DIP	D-16
AD624SD	$-55^{\circ}C$ to $+125^{\circ}C$	16-Lead Ceramic DIP	D-16
AD624SD/883B*	$-55^{\circ}C$ to $+125^{\circ}C$	16-Lead Ceramic DIP	D-16
AD624AChips	$-25^{\circ}C$ to $+85^{\circ}C$	Die	
AD624SChips	$-25^{\circ}C$ to $+85^{\circ}C$	Die	

*See Analog Devices' military data sheet for 883B specifications.